

# AONS66937

100V N-Channel AlphaSGT<sup>™</sup>

Minimum Order Quantity

## **General Description**

- Trench Power AlphaSGT<sup>TM</sup> technology
- 175°C Operating Temperature MSL1 up to 260°C peak reflow

**Orderable Part Number** 

• RoHS 2.0 and Halogen-Free Compliant

## **Product Summary**

 $V_{DS}$ 100V  $I_D$  (at  $V_{GS}$ =10V) 196A R<sub>DS(ON)</sub> (at V<sub>GS</sub>=10V) < 3.9mΩ

### **Applications**

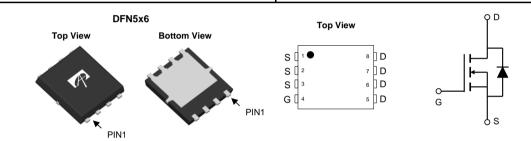
- Hot Swap
- Load Switch

100% UIS Tested 100% Rg Tested

Max Tj=175°C

Form





Package Type

		0 71							
AONS66937		DFN 5x6	Tape & Reel	3000					
Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted									
Parameter		Symbol	Maximum	Units					
Drain-Source Voltage		V <sub>DS</sub>	100	V					
Gate-Source Voltage		$V_{GS}$	±20	V					
Continuous Drain	T <sub>C</sub> =25°C		196						
Current	T <sub>C</sub> =100°C	'D	138	A					
Pulsed Drain Current <sup>Ĉ</sup>		I <sub>DM</sub>	784						
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	70	Α					
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub>	245	mJ					
	T <sub>C</sub> =25°C	Ь	300	W					
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	P <sub>D</sub>	150	¬					
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C					

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	15	20	°C/W			
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		40	50	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.37	0.5	°C/W			



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$		100			V		
I <sub>DSS</sub> Z	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V				1	μA		
			T <sub>J</sub> =55°C			5	μΛ		
$I_{GSS}$	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V				±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		2.1	2.6	3.1	V		
R	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A			3.2	3.9	mΩ		
R <sub>DS(ON)</sub>			T <sub>J</sub> =125°C		5.2	6.3	11177		
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			28		S		
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.7	1	V		
Is	Maximum Body-Diode Continuous Curre	ent			196	Α			
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=200KHz			7300		pF		
Coss	Output Capacitance				1460		pF		
$C_{rss}$	Reverse Transfer Capacitance				22		pF		
$R_g$	Gate resistance	f=1MHz		0.5	1	1.5	Ω		
SWITCHI	NG PARAMETERS	-			-	3	-		
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A			86	120	nC		
$Q_{gs}$	Gate Source Charge				29		nC		
$Q_{gd}$	Gate Drain Charge				10		nC		
Q <sub>oss</sub>	Output Charge	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V			121		nC		
t <sub>D(on)</sub>	Turn-On DelayTime				17.4		ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_{L}$ =2.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			7.2		ns		
t <sub>D(off)</sub>	Turn-Off DelayTime				37		ns		
t <sub>f</sub>	Turn-Off Fall Time				9		ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			50		ns		
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F$ =20A, di/dt=500A/ $\mu$	s		350		nC		

A. The value of  $R_{0,lA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation P<sub>DSM</sub> is based on R <sub>BLA</sub> t≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.
- G. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25° C.

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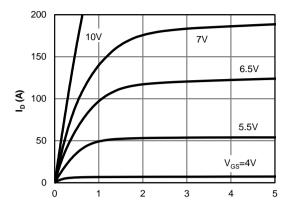
B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C.

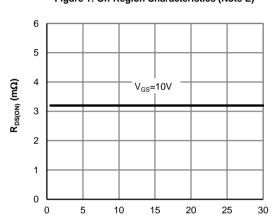
D. The R<sub>0JA</sub> is the sum of the thermal impedance from junction to case R<sub>0JC</sub> and case to ambient.



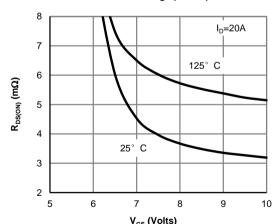
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



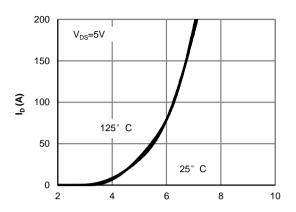
V<sub>DS</sub> (Volts) Figure 1: On-Region Characteristics (Note E)



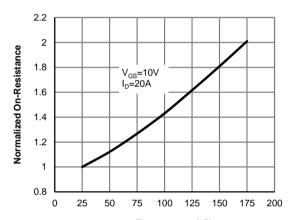
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m I_D}\left({
m A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



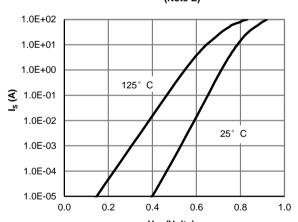
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



V<sub>SD</sub> (Volts)
Figure 6: Body-Diode Characteristics
(Note E)

10

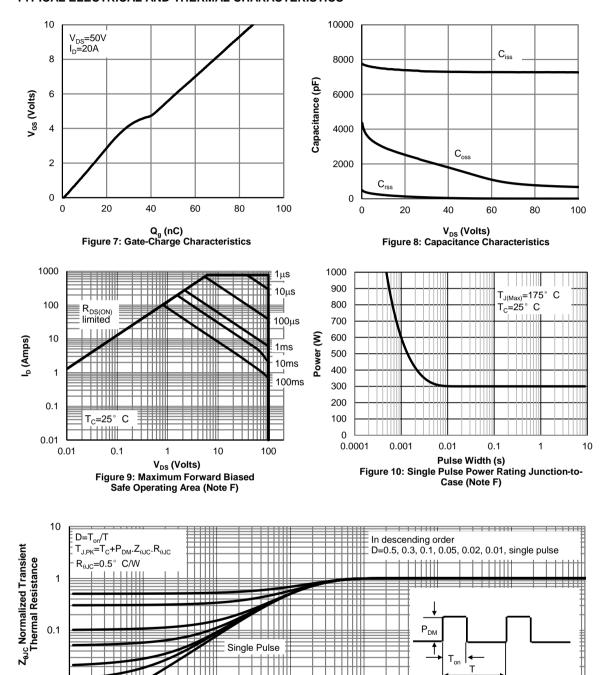
1



0.01 **=** 1E-06

1E-05

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.01

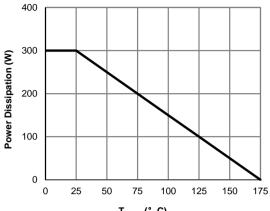
0.1

0.001

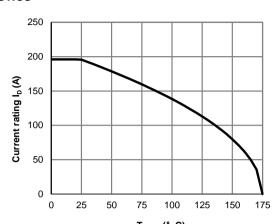
0.0001



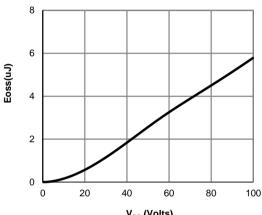
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



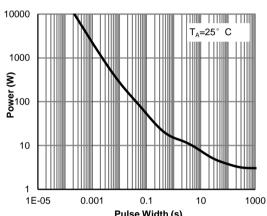
T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)



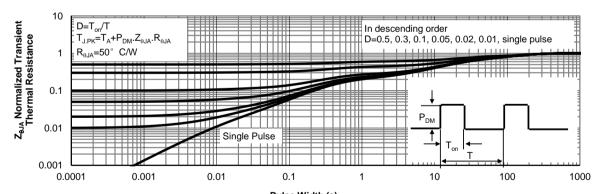
T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)



V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating
Junction-to-Ambient (Note G)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

Figure A: Gate Charge Test Circuit & Waveforms

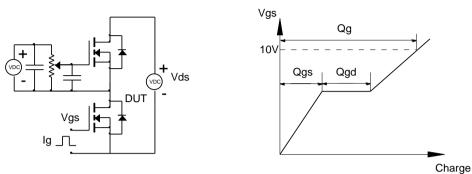


Figure B: Resistive Switching Test Circuit & Waveforms

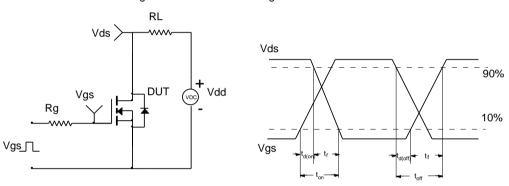


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

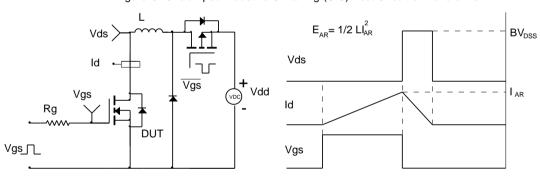


Figure D: Diode Recovery Test Circuit & Waveforms

